

Notice of References Cited	Application/Control No. 10/759,006	Applicant(s)/Patent Under Reexamination NAGAHASHI ET AL.	
	Examiner Javid A. Amini	Art Unit 2628	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,617,528 A	04-1997	Stechmann et al.	715/517
*	B	US-5,960,126 A	09-1999	Nielsen et al.	382/298
*	C	US-6,097,413 A	08-2000	Yamaguchi, Chiseki	347/115
*	D	US-6,349,194 B1	02-2002	Nozaki et al.	434/308
*	E	US-2002/0048413 A1	04-2002	Kusunoki, Naoki	382/282
*	F	US-2002/0059322 A1	05-2002	Miyazaki et al.	707/200
*	G	US-2003/0002733 A1	01-2003	Tsai et al.	382/165
*	H	US-2003/0035917 A1	02-2003	Hyman, Sydney	428/67
*	I	US-2004/0196298 A1	10-2004	Nagahashi et al.	345/619
*	J	US-7,113,306 B1	09-2006	Nakabayashi et al.	358/1.9
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.